Notice of References Cited Application/Control No. 10/655,211 Applicant(s)/Patent Under Reexamination WU, HAN WEN Examiner James W. Cranson Applicant(s)/Patent Under Reexamination WU, HAN WEN Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,336,735	01-2002	Eddins, Michael W.	362/351
*	В	US-6,464,368	10-2002	Chen, Ching-Chao	362/96
	С	US-			
	D	US-			
	Е	US-		·	
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L.	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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